

<b>Notice of References Cited</b>	Application/Control No. 10/673,020		Applicant(s)/Patent Under Reexamination VU ET AL.	
	Examiner PHILIP J. CHEA		Art Unit 2153	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0038319 A1	03-2002	Yahagi, Hironori	707/513
*	B	US-2002/0059583 A1	05-2002	Kim, Moon-Young	725/32
*	C	US-2002/0143819 A1	10-2002	Han et al.	707/513
*	D	US-2002/0198962 A1	12-2002	Horn et al.	709/218
*	E	US-2003/0041147 A1	02-2003	van den Oord et al.	709/227
*	F	US-2003/0140068 A1	07-2003	Yeung, Peter	707/204
*	G	US-7,404,142 B1	07-2008	Tischer, Steven Neil	715/247
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.